

Search Notes

Application/Control No.

10/622,182

Examiner

Jezia Riley

Applicant(s)/Patent under
Reexamination

VAN NESS ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
435	6,7.1,7.2		
436	518,536		
536	23.1,24.3		
536	24.33	3/18/2007	jr

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
435	6		
435	7.1,7.2		
436	518,536		
536/23.1,24.3,24.33			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR